Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/518,722	COOK ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

SEARCHED				
Class	Subclass	Date	Examiner	
382	118	5/9/2006	S.C.	
713	186	5/10/2006	S.C.	
			:	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
382	118	5/10/2006	s.c.	
340	5.52,5.53	5/10/2006	S.C.	
340	5.82,5.83	5/10/2006	S.C.	
726/27,28; 7	713/182-185	5/10/2006	S.C.	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPAT, JPO, EPO, PGPUB, DERWENT	5/10/2006	S.C.	
Consulted with primary examiners Brian Werner, Christopher Revak	5/9/2006	S.C.	
Inventor Name Search	5/10/2006	S.C.	